PRELIMINARY DATA SHEET



# MOS INTEGRATED CIRCUIT $\mu PD4632312A-X$

# 32M-BIT CMOS MOBILE SPECIFIED RAM 2M-WORD BY 16-BIT EXTENDED TEMPERATURE OPERATION

#### Description

The  $\mu$ PD4632312A-X is a high speed, low power, 33,554,432 bits (2,097,152 words by 16 bits) CMOS Mobile Specified RAM featuring Low Power Static RAM compatible function and pin configuration.

The µPD4632312A-X is fabricated with advanced CMOS technology using one-transistor memory cell.

The  $\mu$ PD4632312A-X is packed in 48-pin TAPE FBGA.

#### Features

W

- 2,097,152 words by 16 bits organization
- Fast access time: 60, 65, 75, 85 ns (MAX.)
- Fast page access time: 18, 25, 30 ns (MAX.)
- Byte data control: /LB (I/O0 to I/O7), /UB (I/O8 to I/O15)
- Low voltage operation: 2.7 to 3.1 V (-B60X, -B65X)
  - 2.7 to 3.1 V (Chip), 1.65 to 2.1 V (I/O) (-BE75X, -BE85X)
- Operating ambient temperature: T<sub>A</sub> = -25 to +85 °C
- Output Enable input for easy application
- Chip Enable input: /CS pin
- Standby Mode input: MODE pin
- Standby Mode1: Normal standby (Memory cell data hold valid)
- Standby Mode2: Density of memory cell data hold is variable

vww.Dati	<del>iSheet4U.com</del> μPD4632312A	Access	Operating supply		Operating			Supply current			
		time	volt	voltage		At operating	At standby $\mu A$ (MAX.)				
		ns (MAX.)	١	V te		mA (MAX.)	Density of data hold				
			Chip	I/O	°C		32M bits	16M bits	8M bits	4M bits	0M bit
*	-B60X <sup>Note</sup> , -B65X	60, 65	2.7 to 3.1	-	-25 to +85	50	100	70	60	50	30
*	-BE75X <sup>Note</sup> , -BE85X <sup>Note</sup>	75, 85	2.7 to 3.1	1.65 to 2.1		45					

Note Under development

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#### **Ordering Information**

	Part number	Package	Access time	Operating supply voltage		Operating
			ns (MAX.)	V		temperature
				Chip	I/O	°C
*	μPD4632312AF9-B60X-BC2 <sup>Note</sup>	48-pin TAPE FBGA (8 x 6)	60	2.7 to 3.1	-	–25 to +85
	μPD4632312AF9-B65X-BC2		65			
	μPD4632312AF9-BE75X-BC2 <sup>Note</sup>		75	2.7 to 3.1	1.65 to 2.1	
	μPD4632312AF9-BE85X-BC2 <sup>Note</sup>		85			

Note Under development

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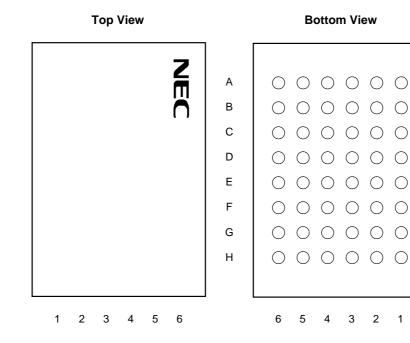
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#### **Pin Configurations**

/xxx indicates active low signal.

48-pin TAPE FBGA (8 x 6)

[ µPD4632312AF9-B60X-BC2 ] [ μPD4632312AF9-B65X-BC2 ]



1							
		1	2	3	4	5	6
	А	/LB	/OE	A0	A1	A2	MODE
	в	I/O8	/UB	A3	A4	/CS	I/O0
	С	I/O9	I/O10	A5	A6	I/O1	I/O2
	D	GND	I/O11	A17	A7	I/O3	Vcc
	Е	Vcc	I/O12	NC	A16	I/O4	GND
.Dat	aŞh	eet411.con 1/014	<sup>1</sup> I/O13	A14	A15	I/O5	I/O6
	G	I/O15	A19	A12	A13	/WE	I/07
	Н	A18	A8	A9	A10	A11	A20
	п	Alo	Ao	A9	AIU	ATT	A20

WWW.

A0 to A20	: Address inputs
I/O0 to I/O15	: Data inputs / outputs
/CS	: Chip select
MODE	: Standby mode
/WE	: Write enable

	6	5	4	3	2	1
А	MODE	A2	A1	A0	/OE	/LB
В	I/O0	/CS	A4	A3	/UB	I/O8
С	I/O2	I/O1	A6	A5	I/O10	I/O9
D	Vcc	I/O3	A7	A17	I/O11	GND
Е	GND	I/O4	A16	NC	I/O12	Vcc
F	I/O6	I/O5	A15	A14	I/O13	I/O14
G	I/07	/WE	A13	A12	A19	I/O15
Н	A20	A11	A10	A9	A8	A18

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/OE	: Output enable
/LB, /UB	: Byte data select
Vcc	: Power supply
GND	: Ground
NC Note	: No connection

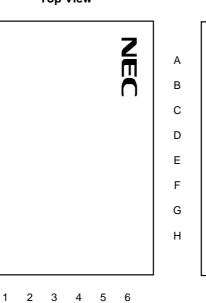
Note Some signals can be applied because this pin is not internally connected.

Remark Refer to Package Drawing for the index mark.

#### 48-pin TAPE FBGA (8 x 6)

#### [ μPD4632312AF9-BE75X-BC2 ] [ μPD4632312AF9-BE85X-BC2 ]

Top View



6	5	4	3	2	1
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$

**Bottom View** 

		1	2	3	4	5	6
	А	/LB	/OE	A0	A1	A2	MODE
	в	I/O8	/UB	A3	A4	/CS	I/O0
	С	I/O9	I/O10	A5	A6	I/O1	I/O2
	D	GND	I/O11	A17	A7	I/O3	Vcc
	Е	VccQ	I/O12	NC	A16	I/O4	GND
	F	I/O14	I/O13	A14	A15	I/O5	I/O6
	G	I/O15	A19	A12	A13	/WE	I/07
www.Dat	aŞh	eet4U8con	<sup>1</sup> A8	A9	A10	A11	A20

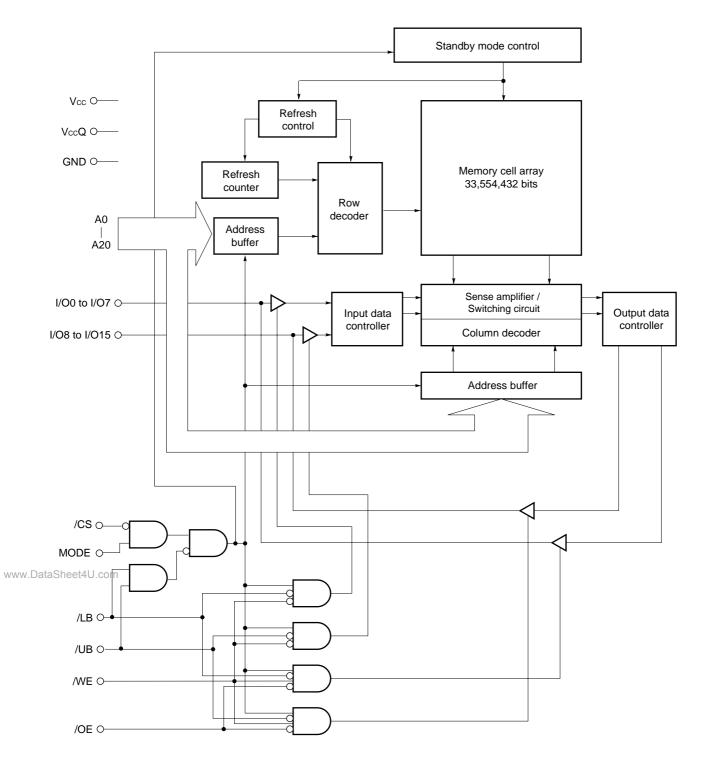
	6	5	4	3	2	1
А	MODE	A2	A1	A0	/OE	/LB
В	I/O0	/CS	A4	A3	/UB	I/O8
С	I/O2	I/O1	A6	A5	I/O10	I/O9
D	Vcc	I/O3	A7	A17	I/O11	GND
Е	GND	I/O4	A16	NC	I/O12	VccQ
F	I/O6	I/O5	A15	A14	I/O13	I/O14
G	I/O7	/WE	A13	A12	A19	I/O15
н	A20	A11	A10	A9	A8	A18

A0 to A20	: Address inputs	/OE	: Output enable
I/O0 to I/O15	: Data inputs / outputs	/LB, /UB	: Byte data select
/CS	: Chip Select	Vcc	: Power supply
MODE	: Standby mode	VccQ	: Input / Output power supply
/WE	: Write enable	GND	: Ground
		NC Note	: No connection

Note Some signals can be applied because this pin is not internally connected.

Remark Refer to Package Drawing for the index mark.

### **Block Diagram**



Remark VccQ is the input / output power supply for -BE75X and -BE85X.

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#### Truth Table

/CS	MODE	/OE	/WE	/LB	/UB	Mode	I/	0	Supply
							I/O0 to I/O7	I/O8 to I/O15	current
Н	Н	×	×	×	×	Not selected (Standby Mode 1)	High-Z	High-Z	ISB1
×	н	×	×	Н	Н	Not selected (Standby Mode 1)	High-Z	High-Z	
×	L	×	×	×	×	Not selected (Standby Mode 2) Note	High-Z	High-Z	Isb2
L	Н	Н	Н	×	×	Output disable	High-Z	High-Z	ICCA
		L	Н	L	L	Word read	Dout	Dout	
				L	Н	Lower byte read	Dout	High-Z	
				Н	L	Upper byte read	High-Z	Dout	
		Н	L	L	L	Word write	Din	Din	
				L	Н	Lower byte write	Din	High-Z	
				Н	L	Upper byte write	High-Z	Din	

Note MODE pin must be fixed to high level except Standby Mode 2. (refer to 2.3 Standby Mode Status Transition).

Remark X: VIH or VIL, H: VIH, L: VIL

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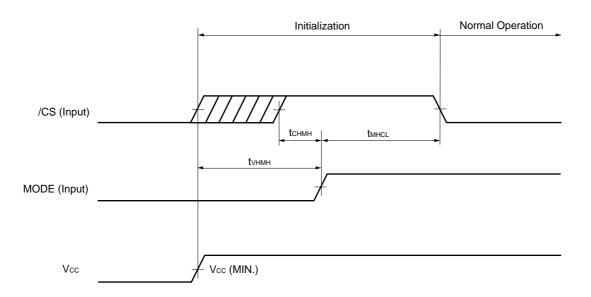
#### 1. Initialization

Initialize the µPD4632312A-X at power application using the following sequence to stabilize internal circuits.

- (1) Following power application, make MODE high level after fixing MODE to low level for the period of tvhmh. Make /CS high level before making MODE high level.
- (2) /CS and MODE are fixed to high level for the period of tMHCL.

Normal operation is possible after the completion of initialization.





Cautions 1. Make MODE low level when starting the power supply.

2. tvhmh is specified from when the power supply voltage reaches the prescribed minimum value (Vcc (MIN.)).

www.DataShaet411 com Timing

Parameter	Symbol	MIN.	MAX.	Unit
Power application to MODE low level hold	t∨нмн	50		μs
/CS high level to MODE high level	tснмн	0		ns
Following power application MODE high level hold to /CS low level	tмнcL	200		μs

#### 2. Partial Refresh

#### 2.1 Standby Mode

In addition to the regular standby mode (Standby Mode 1) with a 32M bits density, Standby Mode 2, which performs partial refresh, is also provided.

#### 2.2 Density Switching

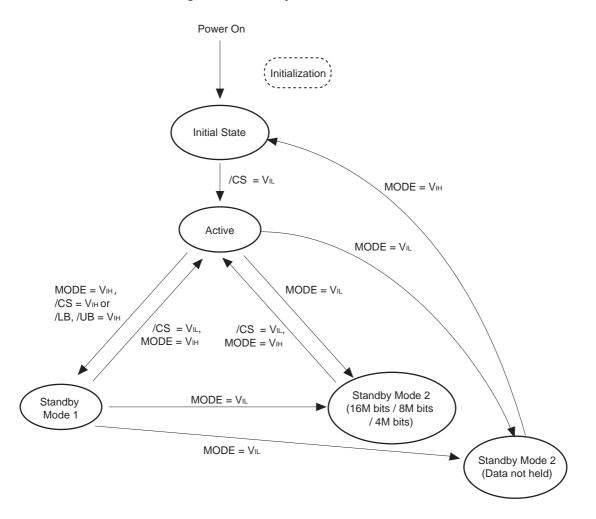
In Standby Mode 2, the densities that can be selected for performing refresh are 16M bits, 8M bits, 4M bits, and 0M bit. The density for performing refresh can be set with the mode register. Once the refresh density has been set in the mode register, these settings are retained until they are set again, while applying the power supply. However, the mode register setting will become undefined if the power is turned off, so set the mode register again after power application. (For how to perform mode register settings, refer to section **4. Mode Register Settings**.)

#### 2.3 Standby Mode Status Transition

In Standby Mode 1, MODE and /CS are high level, or MODE, /LB and /UB are high level. In Standby Mode 2, MODE is low level. In Standby Mode 2, if 0M bit is set as the density, it is necessary to perform initialization the same way as after applying power, in order to return to normal operation from Standby Mode 2. When the density has been set to 16M bits, 8M bits, or 4M bits in Standby Mode 2, it is not necessary to perform initialization to return to normal operation from Standby Mode 2.

For the timing charts, refer to Figure 6-14. Standby Mode 2 (data hold: 16M bits / 8M bits / 4M bits) Entry / Exit Timing Chart, Figure 6-15. Standby Mode 2 (data not held) Entry / Exit Timing Chart.





#### 2.4 Addresses for Which Partial Refresh Is Supported

www.DataShe	et4U.coData hold density	Correspondence address
	16M bits	000000H to 0FFFFH
	8M bits	000000H to 07FFFFH
	4M bits	000000H to 03FFFFH

#### 3. Page Read Operation

#### 3.1 Features of Page Read Operation

Features	8 Words Mode
Page length	8 words
Page read-corresponding addresses	A2, A1, A0
Page read start address	Don't care
Page direction	Don't care
Interrupt during page read operation	Enabled <sup>Note</sup>

**Note** An interrupt is output when /CS = H or in case A3 or a higher address changes.

#### 3.2 Page Length

8 words is supported as the page lengths.

#### 3.3 Page-Corresponding Addresses

The page read-enabled addresses are A2, A1, and A0. Fix addresses other than A2, A1, and A0 during page read operation.

#### 3.4 Page Start Address

Since random page read is supported, any address (A2, A1, A0) can be used as the page read start address.

#### 3.5 Page Direction

Since random page read is possible, there is not restriction on the page direction.

#### 3.6 Interrupt during Page Read Operation

www.DatWhen generating an interrupt during page read, either make /CS high level or change A3 and higher addresses.

#### 3.7 When page read is not used

Since random page read is supported, even when not using page read, random access is possible as usual.

#### 4. Mode Register Settings

The partial refresh density can be set using the mode register. Since the initial value of the mode register at power application is undefined, be sure to set the mode register after initialization at power application. When setting the density of partial refresh, data before entering the partial refresh mode is not guaranteed. (This is the same for resetup.) However, since partial refresh mode is not entered unless MODE = L when partial refresh is not used, it is not necessary to set the mode register. Moreover, when using page read without using partial refresh, it is not necessary to set the mode register.

#### 4.1 Mode Register Setting Method

The mode register setting mode can be entered by successively writing two specific data after two continuous reads of the highest address (1FFFFH). The mode register setting is a continuous four-cycle operation (two read cycles and two write cycles).

Commands are written to the command register. The command register is used to latch the addresses and data required for executing commands, and it does not have an exclusive memory area.

For the timing chart and flow chart, refer to Figure 6-12. Mode Register Setting Timing Chart, Figure 6-13. Mode Register Setting Flow Chart.

Table 4-1. shows the commands and command sequences.

Table 4-1	Command	sequence
-----------	---------	----------

Command sequence	1st bus cycle		2nd bus cycle		3rd bus	s cycle	4th bus cycle		
	(Read cycle)		(Read cycle)		(Write	cycle)	(Write	cycle)	
Partial refresh density	Address Data		Address	Data	Address	Data	Address	Data	
16M bits	1FFFFFH	_	1FFFFFH	-	1FFFFFH	00H	1FFFFFH	04H	
8M bits	1FFFFFH	_	1FFFFFH	Ι	1FFFFFH	00H	1FFFFFH	05H	
4M bits	1FFFFFH	_	1FFFFFH	_	1FFFFFH	00H	1FFFFFH	06H	
0M bit	1FFFFFH	_	1FFFFFH	Ι	1FFFFFH	00H	1FFFFFH	07H	

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4th bus cycle (Write cycle)

I/O	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Mode Register setting	0	0	0	0	0	0	0	0	0	0	0	0	0	PL	Р	D
			Page	length			1	8	3 word	s						
											4					
						I/O1	I/O0	I	Density	y	1					
		I	Partial	refresl	n	0	0	1	6M bit	S	1					
			der	sity		0	1		8M bits	5						
						1	0		4M bits	5						
						1	1		0M bit							

#### 4.2 Cautions for Setting Mode Register

Since, for the mode register setting, the internal counter status is judged by toggling /CS and /OE, toggle /CS at every cycle during entry (read cycle twice, write cycle twice), and toggle /OE like /CS at the first and second read cycles.

If incorrect addresses or data are written, or if addresses or data are written in the incorrect order, the setting of the mode register are not performed correctly.

When the highest address (1FFFFH) is read consecutively three or more times, the mode register setting entries are cancelled.

Once the refresh density has been set in the mode register, these settings are retained until they are set again, while applying the power supply. However, the mode register setting will become undefined if the power is turned off, so set the mode register again after power application.

For the timing chart and flow chart, refer to Figure 6-12. Mode Register Setting Timing Chart, Figure 6-13. Mode Register Setting Flow Chart.

#### 5. Electrical Specifications

#### **Absolute Maximum Ratings**

Parameter	Symbol	Condition	Rat	ting	Unit
			-B60X, -B65X	-BE75X, -BE85X	
Supply voltage	Vcc		-0.5 <sup>Note</sup> to +4.0	-0.5 <sup>Note</sup> to +4.0	V
Input / Output supply voltage	VccQ		-	-0.5 <sup>Note</sup> to +4.0	V
Input / Output voltage	VT		-0.5 <sup>Note</sup> to Vcc + 0.4 (4.0 V MAX.)	–0.5 <sup>Note</sup> to VccQ + 0.4 (4.0 V MAX.)	V
Operating ambient temperature	TA		–25 to +85	–25 to +85	°C
Storage temperature	Tstg		–55 to +125	–55 to +125	°C

Note -1.0 V (MIN.) (Pulse width: 30 ns)

Caution Exposing the device to stress above those listed in Absolute Maximum Rating could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

#### **Recommended Operating Conditions**

Parameter	Symbol	Condition	-B60X,	-B65X	-BE75X,	Unit	
			MIN.	MAX.	MIN.	MAX.	
Supply voltage	Vcc		2.7	3.1	2.7	3.1	V
Input / Output supply voltage	VccQ		-	-	1.65	2.1	V
High level input voltage	VIH		0.8Vcc	Vcc+0.3	0.8VccQ	VccQ+0.3	V
Low level input voltage	VIL		-0.3 <sup>Note</sup>	0.2Vcc	-0.3 <sup>Note</sup>	0.2VccQ	V
Operating ambient temperature	TA		-25	+85	-25	+85	°C

Note -0.5 V (MIN.) (Pulse width: 30 ns)

#### Capacitance (T<sub>A</sub> = 25°C, f = 1 MHz)

www.Da	Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit
vv vv vv . D c	Input capacitance	CIN	V <sub>IN</sub> = 0 V			8	pF
	Input / Output capacitance	Ci/O	$V_{VO} = 0 V$			10	pF

Remarks 1. VIN: Input voltage, VI/O: Input / Output voltage

2. These parameters are not 100% tested.

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	Parameter	Symbol	Test condition	Density of	-	B60X, -B65X	×	Unit
				data hold	MIN.	TYP.	MAX.	
	Input leakage current	lu	$V_{IN} = 0 V \text{ to } V_{CC}$		-1.0		+1.0	μA
	I/O leakage current	Ilo	$V_{I/O} = 0 V$ to $V_{CC}$ , $/CS = V_{IH}$ or		-1.0		+1.0	μA
			$WE = V_{IL} \text{ or } OE = V_{IH}$					
*	Operating supply current	ICCA	/CS = V <sub>IL</sub> , Minimum cycle time, $I_{VO}$ = 0 mA				50	mA
*	Standby supply current	Isb1	/CS $\ge$ Vcc $-$ 0.2 V, MODE $\ge$ Vcc $-$ 0.2 V	32M bits			100	μA
*		ISB2	/CS $\geq$ Vcc $-$ 0.2 V, MODE $\leq$ 0.2 V	16M bits			70	
*				8M bits			60	
*				4M bits			50	
*				0M bit			30	
	High level output voltage	Vон	Іон <b>= –0.5 mA</b>		0.8Vcc			V
	Low level output voltage	Vol	lo∟ = 1 mA				0.2Vcc	V

#### DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted) (1/2)

Remark VIN: Input voltage, VI/O: Input / Output voltage

#### DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted) (2/2)

Parameter	Symbol	Test condition	Density of	-Bl	E75X, -BE8	5X	Uni
			data hold	MIN.	TYP.	MAX.	
Input leakage current	lu	$V_{IN} = 0 V \text{ to } V_{CC}Q$		-1.0		+1.0	μA
I/O leakage current	Ilo	$V_{I/O}$ = 0 V to V <sub>CC</sub> Q, /CS = V <sub>IH</sub> or		-1.0		+1.0	μA
		$WE = V_{IL} \text{ or } OE = V_{IH}$					
Operating supply current	ICCA	/CS = V <sub>IL</sub> , Minimum cycle time, Ivo = 0 mA				45	m/
Standby supply current	ISB1	$/CS \ge V \text{cc}Q - 0.2 \text{ V}, \text{ MODE } \ge V \text{cc}Q - 0.2 \text{ V}$	32M bits			100	μA
	ISB2	/CS $\geq$ VccQ $-$ 0.2 V, MODE $\leq$ 0.2 V	16M bits			70	
			8M bits			60	
taSheet4U.com			4M bits			50	
			0M bit			30	
High level output voltage	Vон	Iон <b>= -0.5 mA</b>		0.8VccQ			V
Low level output voltage	Vol	loL = 1 mA				0.2VccQ	V

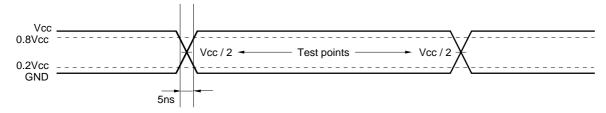
Remark VIN: Input voltage, VI/o: Input / Output voltage

#### AC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)

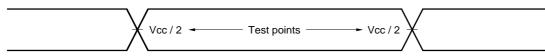
#### AC Test Conditions

#### [-B60X, -B65X]

#### Input Waveform (Rise and Fall Time ≤ 5 ns)

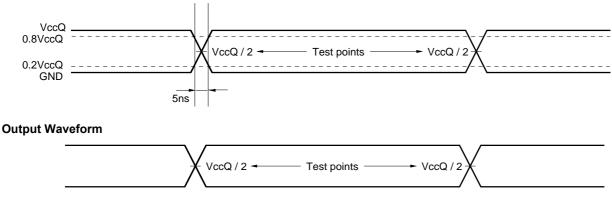


#### **Output Waveform**



#### [-BE75X, -BE85X]

#### Input Waveform (Rise and Fall Time $\leq$ 5 ns)





#### Output Load

AC characteristics directed with the note should be measured with the output load shown in Figure 5-1, Figure 5-2.

# Figure 5-1.

#### [-B60X, -B65X]

C∟: 30 pF

5 pF (tclz, tolz, tblz, tchz, tohz, tbhz)

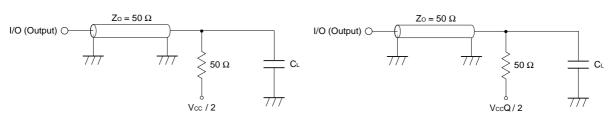


Figure 5-2.

C∟: 30 pF

[-BE75X, -BE85X]

5 pF (tclz, tolz, tblz, tchz, tohz, tbhz)

Remark CL includes capacitance of the probe and jig, and stray capacitance.

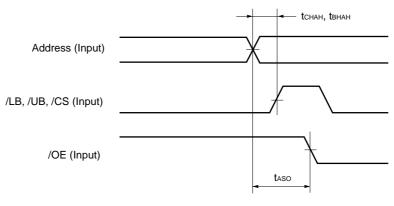
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Parameter	Symbol -B60X		50X	-B65X		-BE75X		-BE85X		Unit	Note
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Read cycle time	trc	65		65		75		85		ns	1
Address access time	taa		60		65		75		85	ns	
/CS access time	tacs		63		65		75		85	ns	
/OE to output valid	toe		45		45		50		55	ns	
/LB, /UB to output valid	tва		63		65		75		85	ns	
Output hold from address change	tон	5		5		5		5		ns	
Page read cycle time	<b>t</b> PRC	18		18		25		30		ns	
Page access time	<b>t</b> PAA		18		18		25		30	ns	
/CS to output in low impedance	tclz	10		10		10		10		ns	2
/OE to output in low impedance	tolz	5		5		5		5		ns	
/LB, /UB to output in low impedance	<b>t</b> BLZ	5		5		5		5		ns	
/CS to output in high impedance	<b>t</b> cHz		25		25		25		25	ns	
/OE to output in high impedance	tонz		25		25		25		25	ns	
/LB, /UB to output in high impedance	tвнz		25		25		25		25	ns	
Address set to /OE low level	taso	0		0		0		0		ns	
/OE high level to address hold	tонан	-5		-5		-5		-5		ns	
/CS high level to address hold	tснан	0		0		0		0		ns	3
/LB, /UB high level to address hold	tвнан	0		0		0		0		ns	3, 4
/CS low level to /OE low level	tclol	0	10,000	0	10,000	0	10,000	0	10,000	ns	5
/OE low level to /CS high level	<b>t</b> olch	45		45		50		55		ns	
/CS high level pulse width	tcp	10		10		10		10		ns	
/LB, /UB high level pulse width	tвр	10		10		10		10		ns	
/OE high level pulse width	top	2	10,000	2	10,000	2	10,000	2	10,000	ns	5

www.DaNoteset4.UOutput load: 30 pF

\*

- 2. Output load: 5 pF
- 3. When taso  $\geq$  | tchah |, | tBHAH |, tchah and tBHAH (MIN.) are -15 ns.



4. tBHAH is specified from when both /LB and /UB become high level.

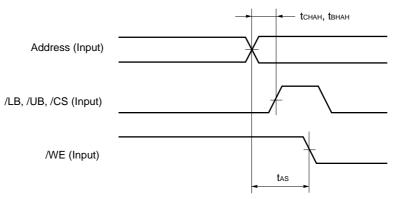
5. tclol and top (MAX.) are applied while /CS is being hold at low level.

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#### Write Cycle

Parameter	Symbol -B60X		50X	-B65X		-BE75X		-BE85X		Unit	Note
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Write cycle time	twc	65		65		75		85		ns	
/CS to end of write	tcw	55		55		60		70		ns	
Address valid to end of write	taw	55		55		60		70		ns	
/LB, /UB to end of write	tвw	55		55		60		70		ns	
Write pulse width	twp	50		50		55		60		ns	
Write recovery time	twr	0		0		0		0		ns	
/CS pulse width	tcp	10		10		10		10		ns	
/LB, /UB high level pulse width	tвр	10		10		10		10		ns	
/WE high level pulse width	<b>t</b> whp	10		10		10		10		ns	
Address setup time	tas	0		0		0		0		ns	
/OE high level to address hold	tонан	-5		-5		-5		-5		ns	
/CS high level to address hold	tснан	0		0		0		0		ns	1
/LB, /UB high level to address hold	tвнан	0		0		0		0		ns	1, 2
Data valid to end of write	tow	30		30		35		35		ns	
Data hold time	tон	0		0		0		0		ns	
/OE high level to /WE set	toes	0	10,000	0	10,000	0	10,000	0	10,000	ns	3
/WE high level to /OE set	tоен	10	10,000	10	10,000	10	10,000	10	10,000	ns	

Notes 1. When tas  $\geq$  | tchah |, | tBHAH | and tcp  $\geq$  18 ns, tchah and tBHAH (MIN.) are -15 ns.



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2. tBHAH is specified from when both /LB and /UB become high level.

3. toes and toeh (MAX.) are applied while /CS is being hold at low level.

#### 6. Timing Charts

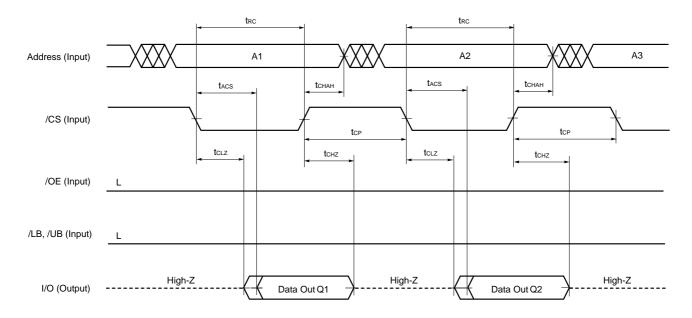
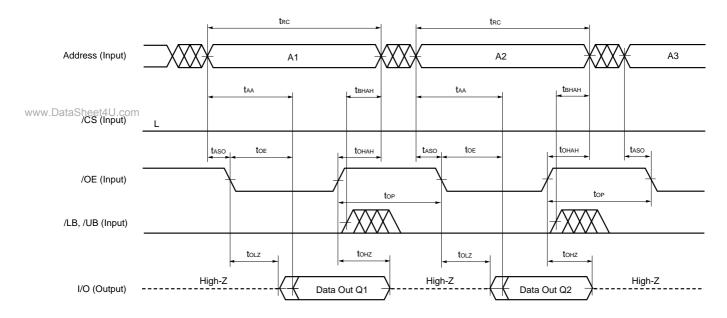


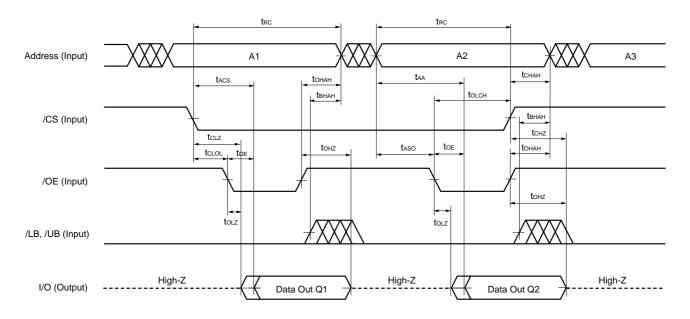
Figure 6-1. Read Cycle Timing Chart 1 (/CS Controlled)

Remark In read cycle, MODE and /WE should be fixed to high level.





**Remark** In read cycle, MODE and /WE should be fixed to high level.



#### Figure 6-3. Read Cycle Timing Chart 3 (/CS, /OE Controlled)

Remark In read cycle, MODE and /WE should be fixed to high level.

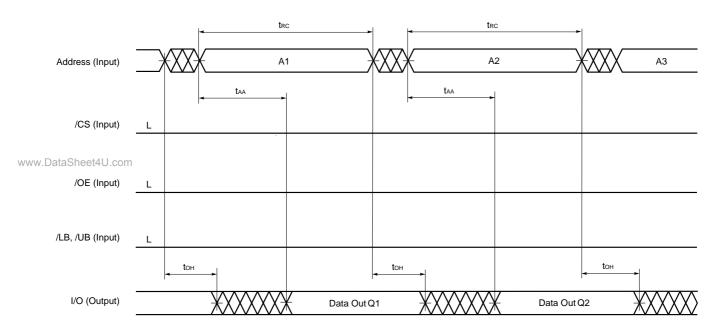


Figure 6-4. Read Cycle Timing Chart 4 (Address Controlled)

Remark In read cycle, MODE and /WE should be fixed to high level.

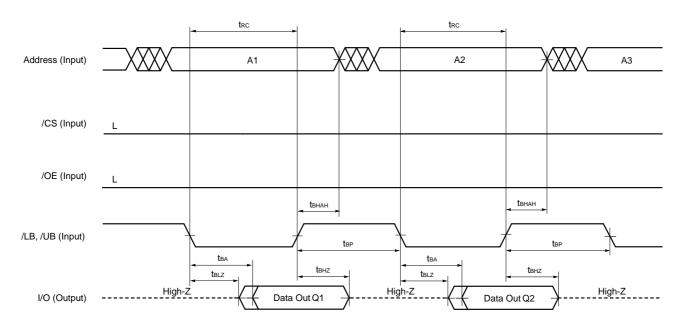


Figure 6-5. Read Cycle Timing Chart 5 (/LB, /UB Controlled)

Remark In read cycle, MODE and /WE should be fixed to high level.

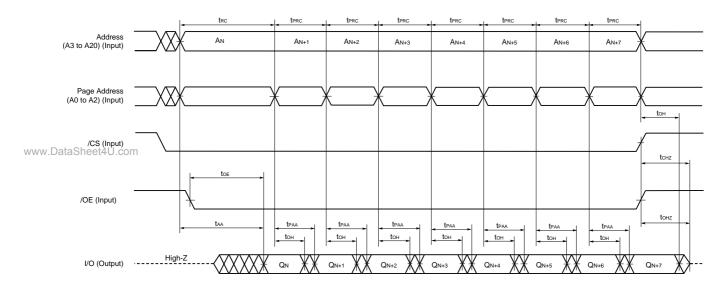
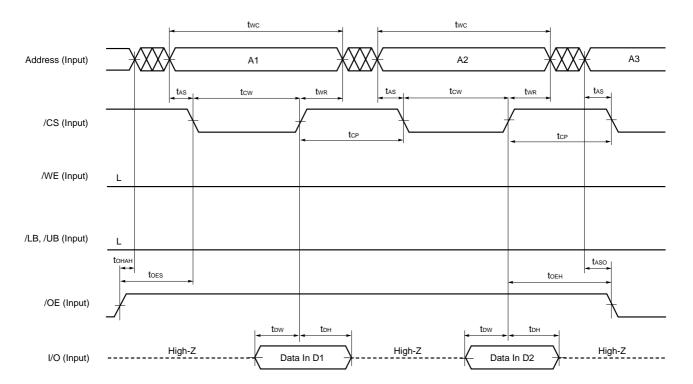


Figure 6-6. Page Read Cycle Timing Chart

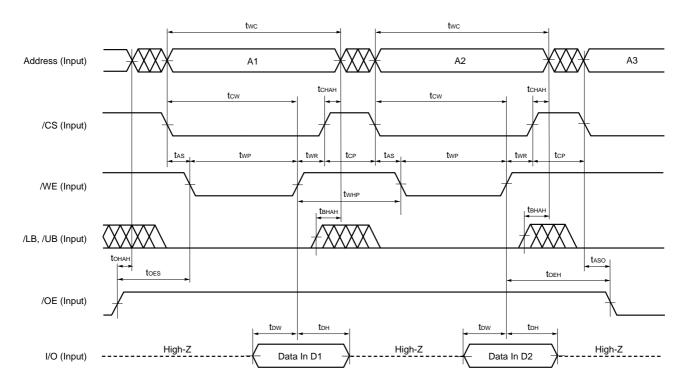
 $\label{eq:Remarks1.} \mbox{ In read cycle, MODE and /WE should be fixed to high level.}$ 

2. /LB and /UB are low level.



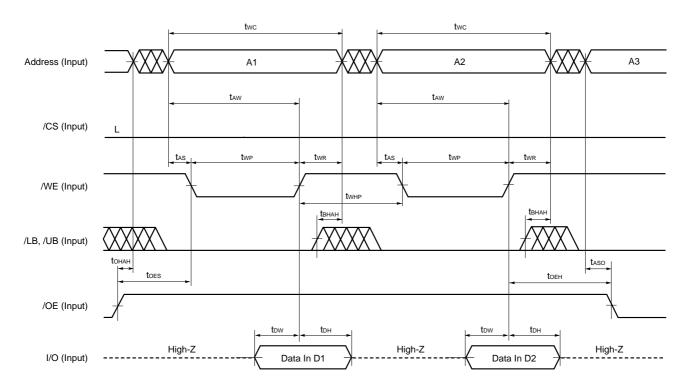
#### Figure 6-7. Write Cycle Timing Chart 1 (/CS Controlled)

- Cautions 1. During address transition, at least one of pins /CS and /WE, or both of /LB and /UB pins should be inactivated.
  - 2. Do not input data to the I/O pins while they are in the output state.
  - 3. In write cycle, MODE and /OE should be fixed to high level.
- Remark Write operation is done during the overlap time of a low level /CS, /WE, /LB and/or /UB.



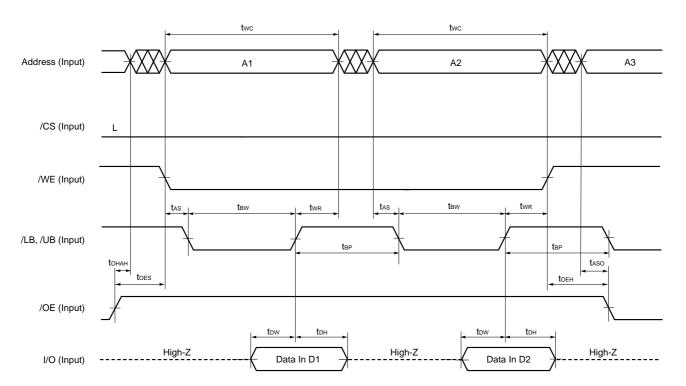
#### Figure 6-8. Write Cycle Timing Chart 2 (/WE Controlled)

- Cautions 1. During address transition, at least one of pins /CS and /WE, or both of /LB and /UB pins should be inactivated.
  - 2. Do not input data to the I/O pins while they are in the output state.
  - 3. In write cycle, MODE and /OE should be fixed to high level.
- Remark Write operation is done during the overlap time of a low level /CS, /WE, /LB and/or /UB.



#### Figure 6-9. Write Cycle Timing Chart 3 (/WE Controlled)

- Cautions 1. During address transition, at least one of pins /CS and /WE, or both of /LB and /UB pins should be inactivated.
  - 2. Do not input data to the I/O pins while they are in the output state.
  - 3. In write cycle, MODE and /OE should be fixed to high level.
- Remark Write operation is done during the overlap time of a low level /CS, /WE, /LB and/or /UB.



#### Figure 6-10. Write Cycle Timing Chart 4 (/LB, /UB Controlled)

- Cautions 1. During address transition, at least one of pins /CS and /WE, or both of /LB and /UB pins should be inactivated.
  - 2. Do not input data to the I/O pins while they are in the output state.
  - 3. In write cycle, MODE and /OE should be fixed to high level.
- Remark Write operation is done during the overlap time of a low level /CS, /WE, /LB and/or /UB.

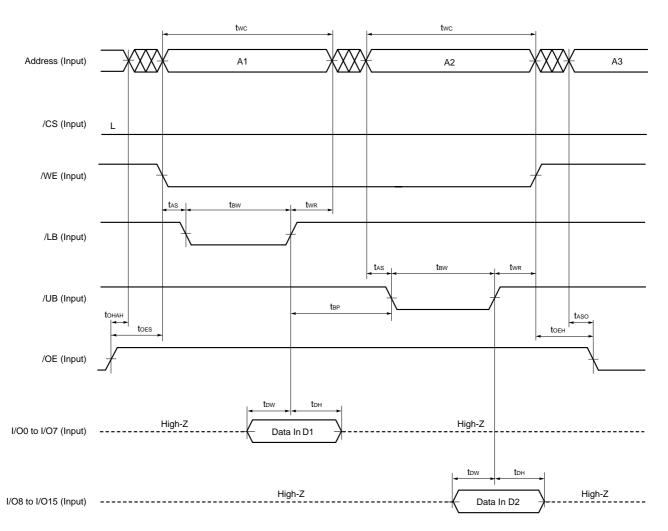
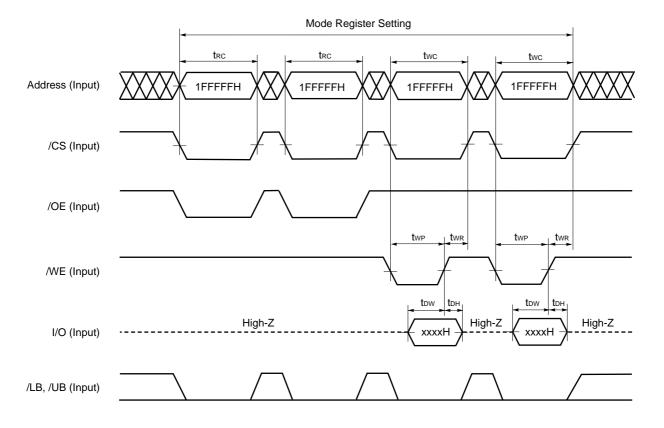


Figure 6-11. Write Cycle Timing Chart 5 (/LB, /UB Independent Controlled)

Cautions 1. During address transition, at least one of pins /CS and /WE, or both of /LB and /UB pins should be www.DataSheet4U.com

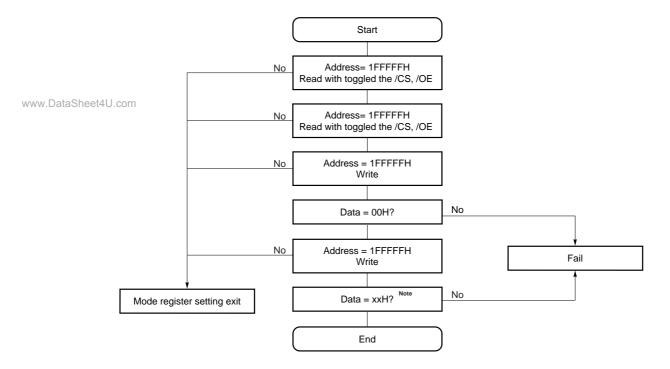
- 2. Do not input data to the I/O pins while they are in the output state.
- 3. In write cycle, MODE and /OE should be fixed to high level.

Remark Write operation is done during the overlap time of a low level /CS, /WE, /LB and/or /UB.



#### Figure 6-12. Mode Register Setting Timing Chart

Figure 6-13. Mode Register Setting Flow Chart

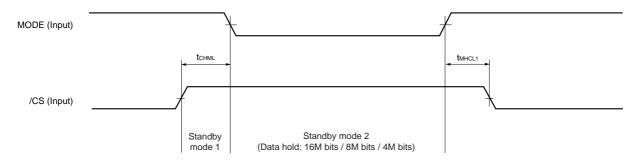


**Note** xxH = 04H, 05H, 06H, 07H

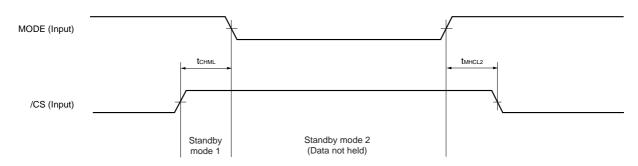
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#### Figure 6-14. Standby Mode 2 (data hold: 16M bits / 8M bits / 4M bits) Entry / Exit Timing Chart



#### Figure 6-15. Standby Mode 2 (data not held) Entry / Exit Timing Chart



#### Standby Mode 2 Entry / Exit Timing

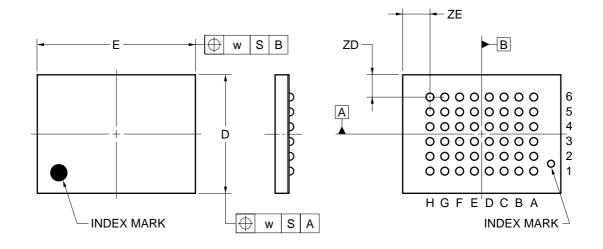
	Parameter	Symbol	MIN.	MAX.	Unit	Note
	Standby mode 2 entry		0		ns	
	/CS high level to MODE low level					
	Standby mode 2 exit to normal operation	tMHCL1	30		ns	1
	MODE high level to /CS low level					
www.Da	Standby mode 2 exit to normal operation taSheet4U.com MODE high level to /CS low level	tmhcl2	200		μs	2

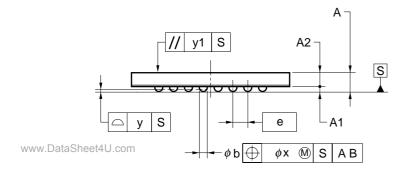
# **Notes 1.** This is the time it takes to return to normal operation from Standby Mode 2 (data hold: 16M bits / 8M bits / 4M bits).

2. This is the time it takes to return to normal operation from Standby Mode 2 (data not held).

#### 7. Package Drawing

# 48-PIN TAPE FBGA (8x6)





ITEM	MILLIMETERS
D	6.0±0.1
Е	8.0±0.1
w	0.2
е	0.75
А	0.94±0.10
A1	0.24±0.05
A2	0.70
b	0.40±0.05
х	0.08
У	0.1
y1	0.2
ZD	1.125
ZE	1.375
	P48F9-75-BC2

# 8. Recommended Soldering Conditions

Please consult with our sales offices for soldering conditions of the  $\mu$ PD4632312A-X.

#### Type of Surface Mount Device

 $\mu$ PD4632312AF9-BC2: 48-pin TAPE FBGA (8 x 6)

#### 9. Revision History

Edition/	Page		Type of	Location	Description
Date	This	Previous	revision		(Previous edition $\rightarrow$ This edition)
	edition	edition			
5th edition/	pp.1, 2	pp.1, 2	Addition	Features, Ordering Information	-B60X: The note under development was added.
Jan. 2003	pp.1, 15	pp.1, 15	Modification	Features, DC Characteristics	Operating supply current (MAX.):
					-B65X: 45 mA $\rightarrow$ 50 mA
					-BE75X, -BE85X: 40 mA $\rightarrow$ 45 mA
					Standby supply current (MAX.):
					Density of data hold 32M bits: 70 $\mu$ A $\rightarrow$ 100 $\mu$ A
					16M bits: 50 $\mu$ A $ ightarrow$ 70 $\mu$ A
					8M bits: 45 $\mu$ A $ ightarrow$ 60 $\mu$ A
					4M bits: 42 $\mu$ A $ ightarrow$ 50 $\mu$ A
					0M bit $: 10 \ \mu A \rightarrow 30 \ \mu A$
	p.17	p.17	Modification	Read Cycle	tolcн (MIN.):
					-BE75X: 45 ns $\rightarrow$ 50 ns
					-BE85X: 45 ns $\rightarrow$ 55 ns

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#### - NOTES FOR CMOS DEVICES -

#### **①** PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

#### ② HANDLING OF UNUSED INPUT PINS FOR CMOS

#### Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the

www.Data Sheet4U.com signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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